

2024 IEEE EDS Kansai Chapter Award

2024 Oct. 11th@ Kansai Colloquium

■ IEEE EDS Kansai Chapter of the Year Award 2024

Author: **Shogo Ogawa**
Title: Improved Scheme for Estimating the
Embedded Gate Resistance to Reproduce
SiC MOSFET Circuit Performance
[IEEE Trans. Electr. Dev.]
Coauthors: **Shogo Ogawa**, Taketoshi Tanaka , and Ken
Nakahara
Affiliation: Rohm Co., Ltd.

■ MFSK Award

Author: **Zhaoxing Qin**
Title: Hybrid CMOS and Pseudo-CMOS Organic
Memory for Flexible Sensors
[IEEE Sensor Journal]
Coauthors: **Kaori Matsumoto**, Zhaoxing Qin, K.
Kuribara, Y. Ogasahara, Takashi Sato
Affiliation: Kyoto University